Unit: mm

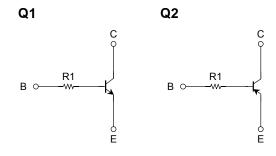
TOSHIBA Transistor Silicon NPN · PNP Epitaxial Type (PCT process) (Bias Resistor Built-in Transistor)

# **RN4990FS**

# Switching, Inverter Circuit, Interface Circuit and Driver Circuit Applications

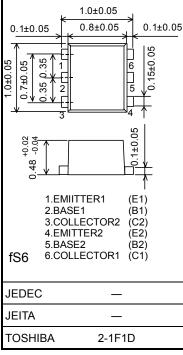
- Two devices are incorporated into a fine pitch small mold (6-pin) package.
- Incorporating a bias resistor into a transistor reduces parts count.
   Reducing the parts count enables the manufacture of ever more compact equipment and lowers assembly cost.

#### **Equivalent Circuit and Bias Resistor Values**



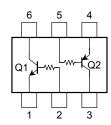
R1: 4.7kΩ

(Q1, Q2 common)



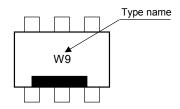
Weight: 0.001g (typ.)

#### **Equivalent Circuit (top view)**



#### Marking

1



# Maximum Ratings (Ta = 25°C) (Q1)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	$V_{CBO}$	20	٧
Collector-emitter voltage	V <sub>CEO</sub>	20	V
Emitter-base voltage	V <sub>EBO</sub>	5	V
Collector current	IC	50	mA

## Maximum Ratings (Ta = 25°C) (Q2)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	$V_{CBO}$	-20	V
Collector-emitter voltage	V <sub>CEO</sub>	-20	V
Emitter-base voltage	V <sub>EBO</sub>	-5	٧
Collector current	IC	<b>-50</b>	mA

# Maximum Ratings (Ta = 25°C) (Q1, Q2 common)

Characteristics	Symbol	Rating	Unit
Collector power dissipation	P <sub>C</sub> (Note)	50	mW
Junction temperature	Tj	150	°C
Storage temperature range	T <sub>stg</sub>	-55~150	°C

Note: Total rating

# Electrical Characteristics (Ta = 25°C) (Q1)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	$V_{CB} = 20 \text{ V}, I_E = 0$	_	_	100	nA
Emitter cut-off current	I <sub>EBO</sub>	$V_{EB} = 5 \text{ V}, I_{C} = 0$	_	_	100	nA
DC current gain	h <sub>FE</sub>	$V_{CE} = 5 \text{ V}, I_{C} = 1 \text{ mA}$	300	_	_	
Collector-emitter saturation voltage	V <sub>CE</sub> (sat)	$I_C = 5 \text{ mA}, I_B = 0.25 \text{ mA}$	_	_	0.15	V
Collector output capacitance	C <sub>ob</sub>	$V_{CB} = 10 \text{ V}, I_{E} = 0, f = 1 \text{ MHz}$	_	1.2	_	pF

## Electrical Characteristics (Ta = 25°C) (Q2)

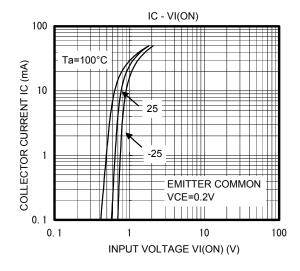
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	$V_{CB} = -20 \text{ V}, I_{E} = 0$	_	_	-100	nA
Emitter cut-off current	I <sub>EBO</sub>	$V_{EB} = -5 \text{ V}, I_C = 0$	_	_	-100	nA
DC current gain	h <sub>FE</sub>	$V_{CE} = -5 \text{ V}, I_{C} = -1 \text{ mA}$	300	_	_	
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	$I_C = -5 \text{ mA}, I_B = -0.25 \text{ mA}$	_	_	-0.15	V
Collector output capacitance	C <sub>ob</sub>	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		1.2	_	pF

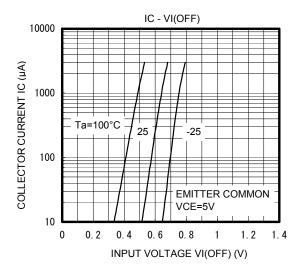
## Electrical Characteristics (Ta = 25°C) (Q1, Q2 common)

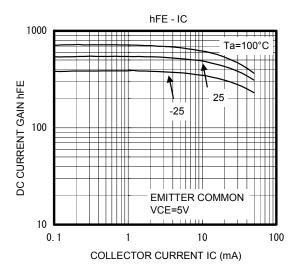
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input resistor	R1	_	3.76	4.7	5.64	kΩ

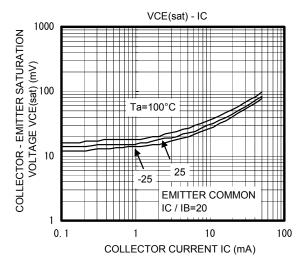
3 2004-06-30

Q1



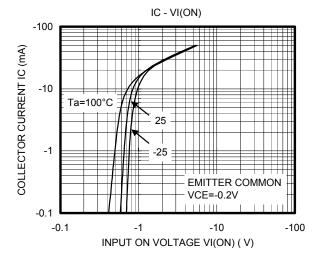


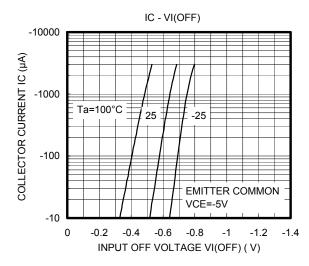


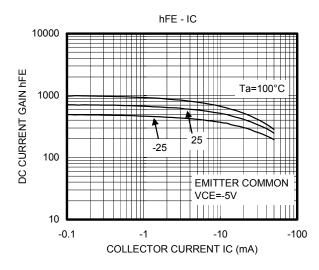


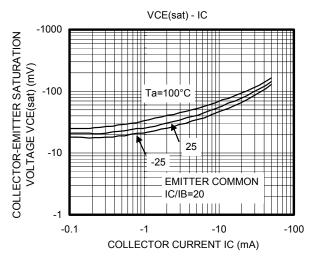
4

Q2









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#### **HANDLING PRECAUTION**

When handling individual devices (which are not yet mounted on a circuit board), be sure that the environment is protected against electrostatic discharge. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.

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#### **RESTRICTIONS ON PRODUCT USE**

Handbook" etc..

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